Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/538,747	MIYOSHI, KENICHI	
Examiner	Art Unit	
TUAN A. PHAM	2618	

	SEARCHED			
Class	Subclass	Date	Examiner	
455	45	8/23/2006	РНАМ	
	46			
370	338			
	208			
	210			
	517	8/23/2004	PHAM	
	_			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	_				

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Consulted with;	8/23/2006	PHAM